International Rectifier

AUIRF3808S

Features

- Advanced Planar Technology
- Low On-Resistance
- Dynamic dV/dT Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

G S

V _{DSS}	75V
R _{DS(on)} typ.	5.9m $Ω$
max.	7.0m Ω
I _D	106A

HEXFET® Power MOSFET

Description

Specifically designed for Automotive applications, this Stripe Planar design of HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications.



G	D	S
Gate	Drain	Source

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T_A) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, VGS @ 10V	106	
I _D @ T _C = 100°C	Continuous Drain Current, VGS @ 10V	75	Α
I _{DM}	Pulsed Drain Current ①	550	
P _D @T _C = 25°C	Maximum Power Dissipation	200	W
	Linear Derating Factor	1.3	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②	430	mJ
I _{AR}	Avalanche Current ①	82	Α
E _{AR}	Repetitive Avalanche Energy ①	See Fig. 12a, 12b, 15, 16	mJ
dv/dt	Peak Diode Recovery ③	5.5	V/ns
T _J	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300	1
	(1.6mm from case)		

Thermal Resistance

	0141100			
Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ®		0.75	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB Mounted, steady-state) ⑦		40	

HEXFET® is a registered trademark of International Rectifier.

^{*}Qualification standards can be found at http://www.irf.com/

Static Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	75			٧	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.086		V/°C	Reference to 25°C, I _D = 1.0mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		5.9	7.0	$m\Omega$	$V_{GS} = 10V, I_D = 82A$ @
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	٧	$V_{DS} = V_{GS}, I_D = 250\mu A$
gfs	Forward Transconductance	100			S	$V_{DS} = 25V, I_{D} = 82A$
I _{DSS}	Drain-to-Source Leakage Current	_		20	μA	$V_{DS} = 75V$, $V_{GS} = 0V$
				250		$V_{DS} = 60V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			200	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-200		$V_{GS} = -20V$

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Q_g	Total Gate Charge		150	220	nC	I _D = 82A
Q_{gs}	Gate-to-Source Charge		31	47		$V_{DS} = 60V$
Q_{gd}	Gate-to-Drain ("Miller") Charge		50	76		V _{GS} = 10V ⁽⁴⁾
$t_{d(on)}$	Turn-On Delay Time		16		ns	$V_{DD} = 38V$
t _r	Rise Time		140			$I_D = 82A$
$t_{d(off)}$	Turn-Off Delay Time		68			$R_G = 2.5\Omega$
t _f	Fall Time		120			V _{GS} = 10V ④
L _D	Internal Drain Inductance		4.5		nΗ	Between lead,
						6mm (0.25in.)
L _S	Internal Source Inductance		7.5			from package
						and center of die contact
C _{iss}	Input Capacitance		5310		pF	$V_{GS} = 0V$
C _{oss}	Output Capacitance		890			$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		130			f = 1.0 MHz, See Fig. 5
C _{oss}	Output Capacitance		6010			$V_{GS} = 0V, V_{DS} = 1.0V, f = 1.0MHz$
C _{oss}	Output Capacitance		570			$V_{GS} = 0V, V_{DS} = 60V, f = 1.0MHz$
C _{oss} eff.	Effective Output Capacitance (Time Related)		1140			$V_{GS} = 0V$, $V_{DS} = 0V$ to $60V$

Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current			106	Α	MOSFET symbol
	(Body Diode)					showing the
I _{SM}	Pulsed Source Current		_	550	Α	integral reverse
	(Body Diode) ②					p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 82A, V_{GS} = 0V $ ④
t _{rr}	Reverse Recovery Time		93	140	ns	$T_J = 25^{\circ}C, I_F = 82A$
Q _{rr}	Reverse Recovery Charge		340	510	nC	di/dt = 100A/μs ④
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)				

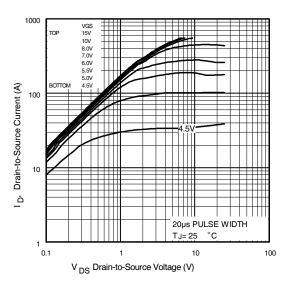
Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).
- ② Starting $T_J = 25$ °C, L = 0.130mH $R_G = 25\Omega$, $I_{AS} = 82$ A. (See Figure 12).
- $\label{eq:loss} \mbox{ $I_{SD} \leq 82A$, $di/dt \leq 310A/\mu s$, $V_{DD} \leq V_{(BR)DSS}$, } \\ \mbox{ $T_{J} \leq 175^{\circ}C$ }$
- 4 Pulse width \leq 400 μ s; duty cycle \leq 2%.
- $\ ^{\circ}$ C $_{oss}$ eff. is a fixed capacitance that gives the same charging time as C $_{oss}$ while V $_{DS}$ is rising from 0 to 80% V $_{DSS}$.
- $\mbox{\^{e}}$ Limited by T_{Jmax} , see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.

Qualification Information[†]

		Automotive (per AEC-Q101) ††						
Qualification	n Level	Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.						
Moisture Sei	nsitivity Level	D2Pak	MSL1					
	Machine Model	Class M4 (+/- 800V) †††						
		AEC-Q101-002						
	Human Body Model		Class H	2 (+/- 4000V)) †††			
ESD		AEC-Q101-001						
	Charged Device Model	Class C5 (+/- 2000V) †††						
		AEC-Q101-005						
RoHS Comp	liant	Yes						

- † Qualification standards can be found at International Rectifier's web site: http://www.irf.com/
- †† Exceptions (if any) to AEC-Q101 requirements are noted in the qualification report.
- ††† Highest passing voltage.



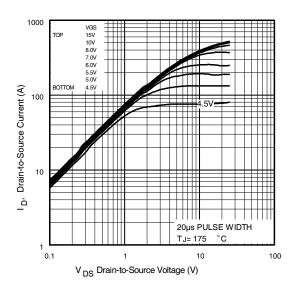
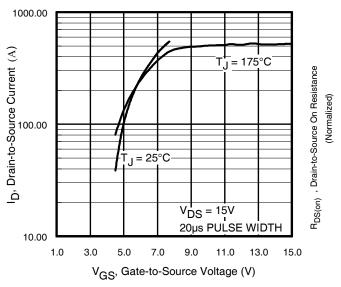


Fig 1. Typical Output Characteristics

Fig 2. Typical Output Characteristics



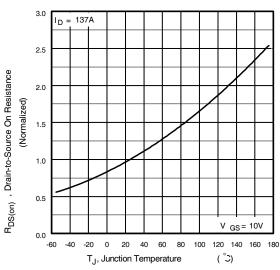
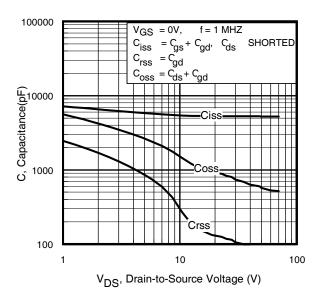


Fig 3. Typical Transfer Characteristics

Fig 4. Normalized On-Resistance Vs. Temperature



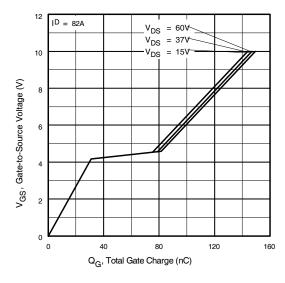
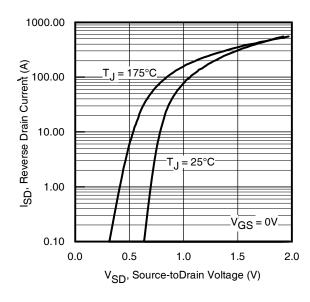


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage



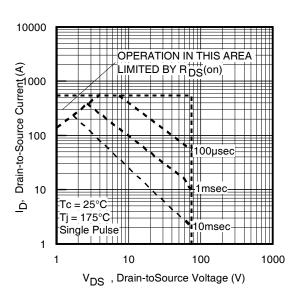


Fig 7. Typical Source-Drain Diode Forward Voltage

Fig 8. Maximum Safe Operating Area

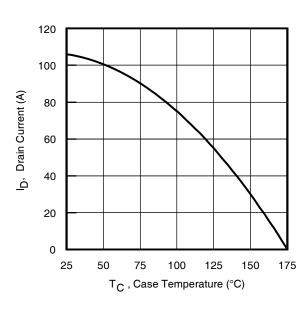


Fig 9. Maximum Drain Current Vs. Case Temperature

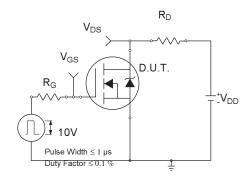


Fig 10a. Switching Time Test Circuit

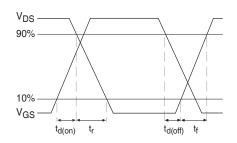


Fig 10b. Switching Time Waveforms

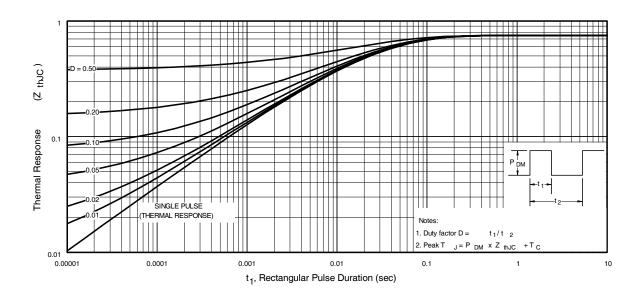


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

 I_D

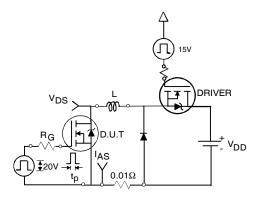


Fig 12a. Unclamped Inductive Test Circuit

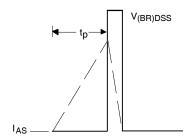


Fig 12b. Unclamped Inductive Waveforms

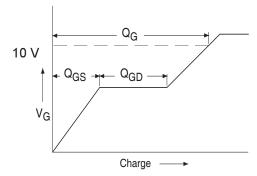
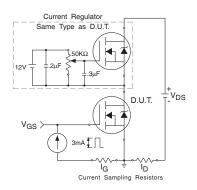


Fig 13a. Basic Gate Charge Waveform



TOP 34A 58A 640 воттом 82A E_{AS} , Single Pulse Avalanche Energy (mJ) 480 320 160 25 50 75 125 150 (°C) Starting Tj, Junction Temperature

800

Fig 12c. Maximum Avalanche Energy Vs. Drain Current

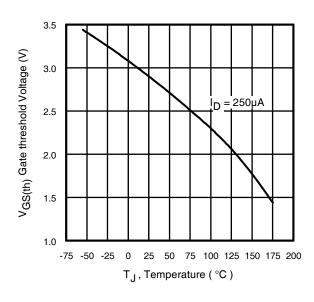


Fig 14. Threshold Voltage Vs. Temperature

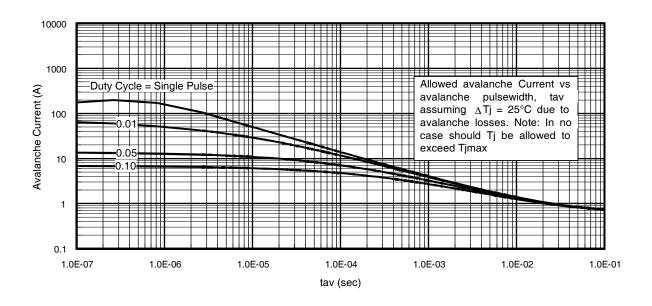
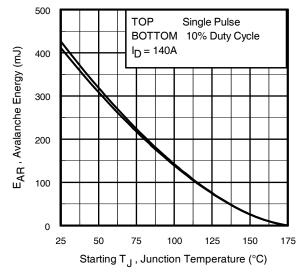


Fig 15. Typical Avalanche Current Vs. Pulsewidth



Notes on Repetitive Avalanche Curves, Figures 15, 16: (For further info, see AN-1005 at www.irf.com)

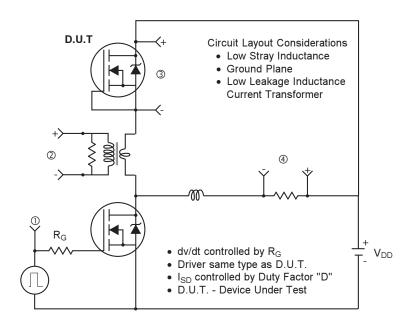
- 1. Avalanche failures assumption:
- Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax} . This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long asT_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. $P_{D \text{ (ave)}}$ = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16).
 - t_{av} = Average time in avalanche.
 - D = Duty cycle in avalanche = $t_{av} \cdot f$

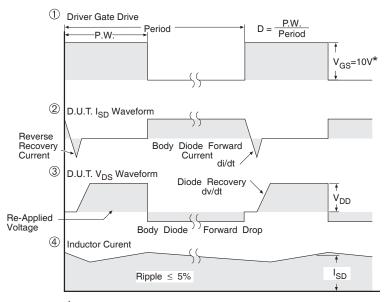
 $Z_{th,JC}(D, t_{av})$ = Transient thermal resistance, see figure 11)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \triangle T / \; Z_{thJC} \\ I_{av} &= 2\triangle T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$

Fig 16. Maximum Avalanche Energy Vs. Temperature

Peak Diode Recovery dv/dt Test Circuit





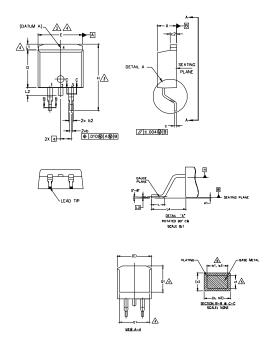
* V_{GS} = 5V for Logic Level Devices

Fig 17. For N-channel HEXFET® power MOSFETs



D²Pak (TO-263AB) Package Outline

Dimensions are shown in millimeters (inches)



NOTES:

- 1, DIMENSIONING AND TOLERANCING PER ASME Y14,5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3) DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH SHALL NOT EXCEED 0.127 [.005*] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5 DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.
- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S	DIMENSIONS					
B	MILLIMETERS		INC	HES	O T E S	
0 L	MIN.	MAX.	MIN.	MAX.	Š	
Α	4.06	4.83	.160	.190		
A1	0.00	0.254	.000	.010		
ь	0.51	0.99	.020	.039		
ь1	0.51	0.89	.020	.035	5	
b2	1.14	1.78	.045	.070		
ь3	1,14	1,73	.045	.068	5	
c	0.38	0.74	.015	.029		
c1	0.38	0.58	.015	.023	5	
c2	1,14	1,65	.045	.065		
D	8.38	9,65	,330	.380	3	
D1	6.86	-	.270		4	
Ε	9.65	10,67	.380	.420	3,4	
E1	6.22	-	.245		4	
е	2,54	BSC	.100	BSC		
Н	14.61	15.88	.575	.625	1	
L	1.78	2,79	,070	.110		
L1	-	1.65	-	.066	4	
L2	1.27	1,78	-	.070		
L3	0.25	BSC	.010	BSC		
L4	4.78	5.28	.188	.208		

LEAD ASSIGNMENTS

HEXFET

1.- GATE

2, 4.- DRAIN

IGBTs, CoPACK

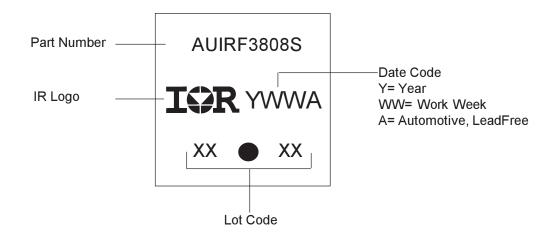
1,- GATE
2, 4,- COLLECTOR
3.- EMITTER

DIODES

1,- ANODE *

* PART DEPENDENT

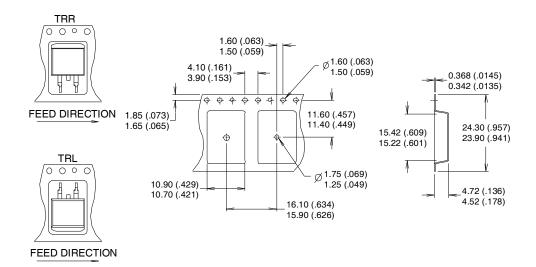
D²Pak (TO-263AB) Part Marking Information

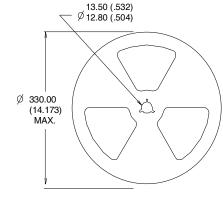


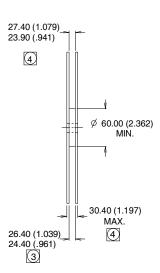
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

D²Pak (TO-263AB) Tape & Reel Information

Dimensions are shown in millimeters (inches)







NOTES:

- 1. COMFORMS TO EIA-418.

- 2. CONTROLLING DIMENSION: MILLIMETER.

 DIMENSION MEASURED @ HUB.

 MICLUDES FLANGE DISTORTION @ OUTER EDGE.

Ordering Information

Base part number	Package Type	Standard Pack		Complete Part Number
		Form	Quantity	
AUIRF3808S	D2Pak	Tube	50	AUIRF3808S
		Tape and Reel Left	800	AUIRF3808STRL
		Tape and Reel Right	800	AUIRF3808STRR

AUIRF3808S

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For technical support, please contact IR's Technical Assistance Center http://www.irf.com/technical-info/

WORLD HEADQUARTERS:

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